

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/561,916 MAEDA ET AL.	
		Examiner	Art Unit Patricia Leith	1655 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 06263790	09-1993	JP	Shimono et al.	----
	O	JP 05013647	04-1993	JP	Ito et al.	full translation
	P					
	Q					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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